

CHIP COIL (CHIP INDUCTORS) LQH32MN□□□□23L REFERENCE SPECIFICATION**1.Scope**

This reference specification applies to LQH32MN Series, Chip coil (Chip Inductors).

2.Part Numbering

(ex) LQ H 32 M N 1R0 M 2 3 L
 Product ID Structure Dimension (L×W) Applications and Characteristics Category Inductance Tolerance Features Electrode Packaging
 L:Taping

3.Rating

- Operating Temperature Range -40 to +85°C
- Storage Temperature Range. -40 to +85°C

Customer Part Number	MURATA Part Number	Inductance		Q (min.)	DC Resistance (Ω max)	Self Resonant Frequency (MHz min)	Rated Current (mA)
		(μH)	Tolerance (%)				
	LQH32MN1R0M23L	1.0	M:±20	20	0.5	100	445
	LQH32MN1R2M23L	1.2			425		
	LQH32MN1R5M23L	1.5	M:±20 K:±10		0.6	75	400
	LQH32MN1R5K23L						
	LQH32MN1R8M23L	1.8			0.7	60	390
	LQH32MN1R8K23L						
	LQH32MN2R2M23L	2.2			0.8	50	370
	LQH32MN2R2K23L						
	LQH32MN2R7M23L	2.7			0.9	43	320
	LQH32MN2R7K23L						
	LQH32MN3R3M23L	3.3			1.0	38	300
	LQH32MN3R3K23L						
	LQH32MN3R9M23L	3.9			1.1	35	290
	LQH32MN3R9K23L						
	LQH32MN4R7M23L	4.7			1.2	31	270
	LQH32MN4R7K23L						
	LQH32MN5R6M23L	5.6			1.3	28	250
	LQH32MN5R6K23L						
	LQH32MN6R8M23L	6.8			1.5	25	240
	LQH32MN6R8K23L						
	LQH32MN8R2M23L	8.2			1.6	23	225
	LQH32MN8R2K23L						
	LQH32MN100K23L	10	K:±10 J:± 5	35	1.8	20	190
	LQH32MN100J23L						
	LQH32MN120K23L	12			2.0	18	180
	LQH32MN120J23L						
	LQH32MN150K23L	15			2.2	16	170
	LQH32MN150J23L						
	LQH32MN180K23L	18			2.5	15	165
	LQH32MN180J23L						
	LQH32MN220K23L	22			2.8	14	150
	LQH32MN220J23L						

* 27 μH and more value are shown in next page.

Customer Part Number	MURATA Part Number	Inductance		Q (min.)	DC Resistance (Ω max)	Self Resonant Frequency (MHz min)	Rated Current (mA)	
		(μH)	Tolerance (%)					
	LQH32MN270K23L	27	K:±10 J:± 5	35	3.1	13	125	
	LQH32MN270J23L							
	LQH32MN330K23L	33		40		3.5	12	115
	LQH32MN330J23L							
	LQH32MN390K23L	39				11	3.9	110
	LQH32MN390J23L							
	LQH32MN470K23L	47				4.3	100	
	LQH32MN470J23L							
	LQH32MN560K23L	56				4.9	10	85
	LQH32MN560J23L							
	LQH32MN680K23L	68				5.5	9.0	80
	LQH32MN680J23L							
	LQH32MN820K23L	82				6.2	8.5	70
	LQH32MN820J23L							
	LQH32MN101K23L	100				7.0	8.0	80
	LQH32MN101J23L							
	LQH32MN121K23L	120				8.0	7.5	75
	LQH32MN121J23L							
	LQH32MN151K23L	150				9.3	7.0	70
	LQH32MN151J23L							
	LQH32MN181K23L	180				10.2	6.0	65
	LQH32MN181J23L							
	LQH32MN221K23L	220				11.8	5.5	
	LQH32MN221J23L							
	LQH32MN271K23L	270				12.5	5.0	50
	LQH32MN271J23L							
	LQH32MN331K23L	330				13.0		
	LQH32MN331J23L							
	LQH32MN391K23L	390		22.0	5.0	50		
	LQH32MN391J23L							
	LQH32MN471K23L	470		25.0			5.0	45
	LQH32MN471J23L							
	LQH32MN561K23L	560		28.0	5.0	40		
	LQH32MN561J23L							

4. Testing Conditions

<Unless otherwise specified>

Temperature : Ordinary Temperature (15 to 35°C)

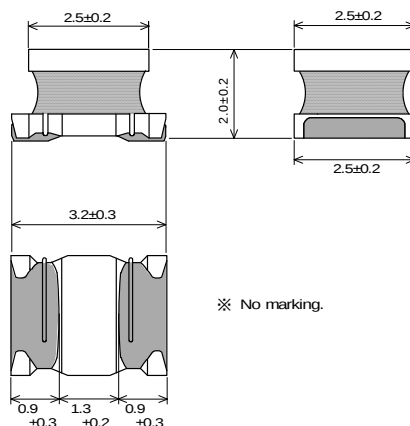
Humidity : Ordinary Humidity (25 to 85 %(RH))

<In case of doubt>

Temperature : 20 ± 2°C

Humidity : 60 to 70 %(RH)

Atmospheric Pressure : 86 to 106 kPa

5.Appearance and Dimensions

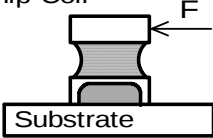
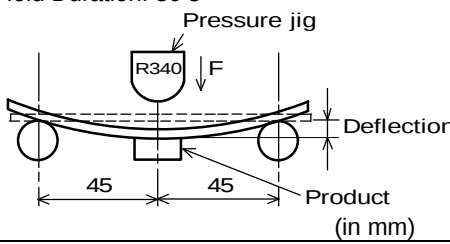
■ Unit Mass (Typical value)
0.060g

(in mm)

6.Electrical Performance

No.	Item	Specification	Test Method
6.1	Inductance	Inductance shall meet item 3.	Measuring Equipment: Agilent 4192A or equivalent Measuring Frequency: 1MHz / 1.0 to 390 μ H 1kHz / 470 to 560 μ H
6.2	Q		Measuring Equipment: Agilent 4192A or equivalent Measuring Frequency: 1MHz / 1.0 to 82 μ H 796kHz / 100 to 560 μ H
6.3	DC Resistance	DC Resistance shall meet item 3.	Measuring Equipment: Digital multi meter
6.4	Self Resonant Frequency(S.R.F)	S.R.F shall meet item 3.	Measuring Equipment: Agilent 4291A or equivalent
6.5	Rated Current	Self temperature rise shall be limited to 20°C max. Inductance Change : within $\pm 10\%$	The rated current is applied.
6.6	Temperature Characteristics	Temperature Coefficient 220 to 1400 PPM/°C	Temperature coefficient on the basis of step 3 shall meet specification after tested as follows.It shall be subjected to the condition of Table 1, and its inductance shall be measured at each step after reaching the thermal equilibrium and be calculated. <u>Table 1</u> Step1/+20 $\pm$ 2°C Step4/+85 $\pm$ 2°C Step2/ -25 $\pm$ 2°C Step5/+20 $\pm$ 2°C Step3/+20 $\pm$ 2°C

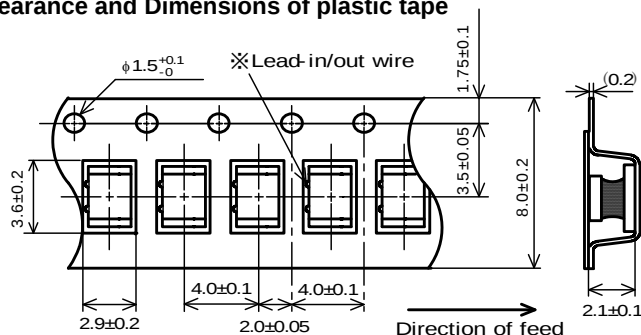
7.Mechanical Performance

No.	Item	Specification	Test Method
7.1	Shear Test	Chip coil shall not be damaged.	Substrate: Glass-epoxy substrate Applied Direction : Chip Coil  Force: 10N Hold Duration: 5 $\pm$ 1s
7.2	Bending Test		Substrate: Glass-epoxy substrate (100 × 40 × 1.6mm) Speed of Applying Force: 1mm / s Deflection: 2mm Hold Duration: 30 s 
7.3	Vibration		Oscillation Frequency: 10 to 55 to 10Hz for 1 minute Total Amplitude:1.5mm Testing Time: A period of 2 hours in each of 3 mutually perpendicular directions. (Total 6 hours)

No.	Item	Specification	Test Method
7.4	Solderability	The wetting area of the electrode shall be at least 90% covered with new solder coating.	Flux: Ethanol solution of rosin, 25(wt)% (Immersed for 5s to 10s) Solder: Sn-3.0Ag-0.5Cu Pre-Heating: 150±10°C / 60 to 90seconds Solder Temperature: 240±5°C Immersion Time: 3±1 s
7.5	Resistance to Soldering Heat	Appearance: No damage Inductance Change: within ± 5%	Flux: Ethanol solution of rosin, 25(wt)% (Immersed for 5s to 10s) Solder: Sn-3.0Ag-0.5Cu Pre-Heating: 150±10°C / 60 to 90seconds Solder Temperature: 270±5°C Immersion Time: 10±1 s Then measured after exposure in the room condition for 24±2 hours.

8.Environmental Performance (It shall be soldered on the substrate.)

No.	Item	Specification	Test Method
8.1	Heat Resistance	Appearance: No damage Inductance Change : within ±5% Q-factor Change : within ±20%	Temperature: 85±2°C Time: 1 000± ⁴⁸ ₀ hours Then measured after exposure in the room condition for 24±2 hours.
8.2	Cold Resistance		Temperature: -40±2°C Time: 1000± ⁴⁸ ₀ hours Then measured after exposure in the room condition for 24±2 hours.
8.3	Humidity		Temperature: 40±2°C Humidity: 90 to 95%(RH) Time: 1000± ⁴⁸ ₀ hours Then measured after exposure in the room condition for 24±2 hours.
8.4	Temperature Cycle		1 cycle: 1 step: -40±2°C / 30±3 min 2 step: Ordinary temp. / 10 to 15 min 3 step: +85±2°C / 30±3 min 4 step: Ordinary temp. / 10 to 15 min Total of 10 cycles Then measured after exposure in the room condition for 24±2 hours.

9. Specification of Packaging**9.1 Appearance and Dimensions of plastic tape**

※The packing directions of the chip coil in taping are unified with the in/out positions of the lead wire.

Dimension of the Cavity is measured at the bottom side.

(in mm)

9.2 Specification of Taping

(1) Packing quantity (standard quantity)

2,000 pcs / reel

(2) Packing Method

Products shall be packed in the each embossed cavity of plastic tape and sealed by cover tape.

(3) Sprocket hole

The sprocket holes are to the right as the tape is pulled toward the user.

(4) Spliced point

Plastic tape and Cover tape has no spliced point.

(5) Missing components number

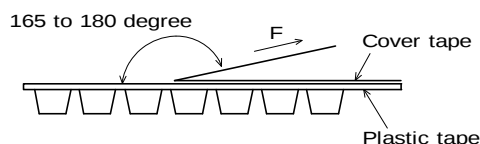
Missing components number within 0.1 % of the number per reel or 1 pc., whichever is greater, and are not continuous. The specified quantity per reel is kept.

9.3 Pull Strength

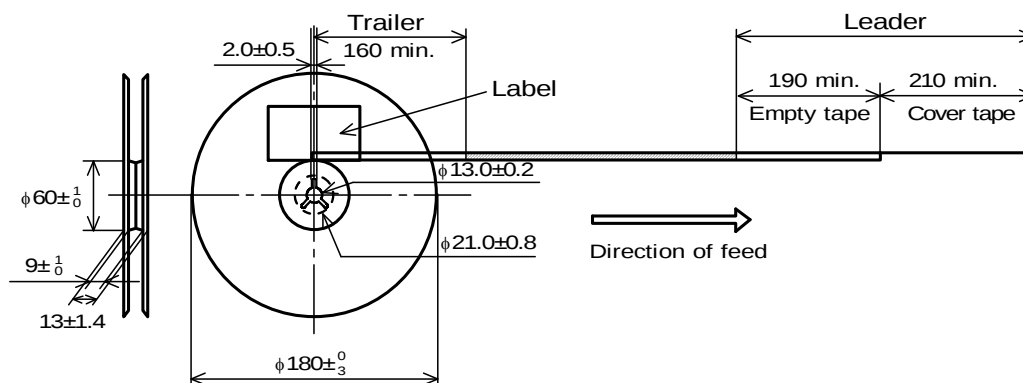
Embossed carrier tape	10N min.
Cover tape	5N min.

9.4 Peeling off force of cover tape

Speed of Peeling off	300mm/min
Peeling off force	0.2 to 0.7N (minimum value is typical)

**9.5 Dimensions of Leader-tape, Trailer and Reel**

There shall be leader-tape (cover tape) and trailer-tape (empty tape) as follows.

**9.6 Marking for reel**

Customer part number, MURATA part number, Inspection number(*1), RoHS marking(*2), Quantity etc ...

*1) <Expression of Inspection No.>

$\square\square$	0000	xxx
(1)	(2)	(3)

(1) Factory Code

(2) Date

First digit : Year / Last digit of year

Second digit : Month / Jan. to Sep. → 1 to 9, Oct. to Dec. → O, N, D

Third, Fourth digit : Day

(3) Serial No.

*2) « Expression of RoHS marking » ROHS – Y (Δ)

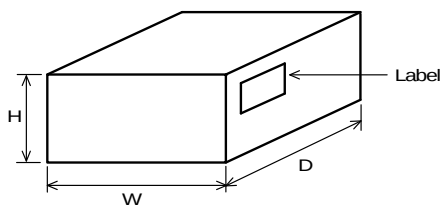
(1) (2)

(1) RoHS regulation conformity parts.

(2) MURATA classification number

9.7 Marking for Outside package (corrugated paper box)

Customer name, Purchasing order number, Customer part number, MURATA part number, RoHS marking (*2), Quantity, etc ...

9.8. Specification of Outer Case

Outer Case Dimensions (mm)			Standard Reel Quantity in Outer Case (Reel)
W	D	H	
186	186	93	5

* Above Outer Case size is typical. It depends on a quantity of an order.

10. ⚠ Caution**Limitation of Applications**

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

- | | |
|--|--|
| (1) Aircraft equipment | (7) Traffic signal equipment |
| (2) Aerospace equipment | (8) Disaster prevention / crime prevention equipment |
| (3) Undersea equipment | (9) Data-processing equipment |
| (4) Power plant control equipment | (10) Applications of similar complexity and /or reliability requirements to the applications listed in the above |
| (5) Medical equipment | |
| (6) Transportation equipment (vehicles, trains, ships, etc.) | |

11. Notice

This product is designed for solder mounting.

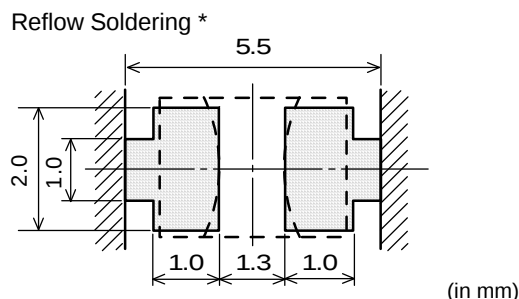
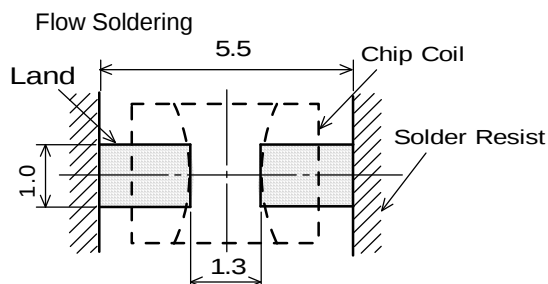
Please consult us in advance for applying other mounting method such as conductive adhesive.

11.1 Land pattern designing

Recommended land patterns for flow and reflow soldering are as follows:

These have been designed for Electric characteristics and solderability.

Please follow the recommended patterns. Otherwise, their performance which includes electrical performance or solderability may be affected, or result to "position shift" in soldering process.



* Applicable to flow soldering.

11.2 Flux, Solder

Flux	• Use rosin-based flux. • Don't use highly acidic flux with halide content exceeding 0.2(wt)% (chlorine conversion value). • Don't use water-soluble flux.
Solder	• Use Sn-3.0Ag-0.5Cu solder • Standard thickness of solder paste : 200 μ m to 300 μ m

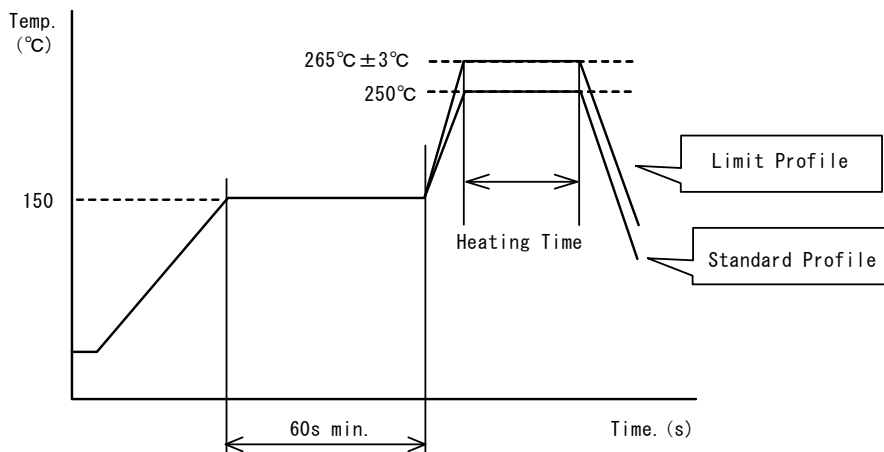
Other flux (except above) Please contact us for details, then use.

11.3 Flow soldering conditions / Reflow soldering conditions

- Pre-heating should be in such a way that the temperature difference between solder and product surface is limited to 150°C max. Cooling into solvent after soldering also should be in such a way that the temperature difference is limited to 100°C max. Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of product quality.
- Standard soldering profile and the limit soldering profile is as follows. The excessive limit soldering conditions may cause leaching of the electrode and / or resulting in the deterioration of product quality.

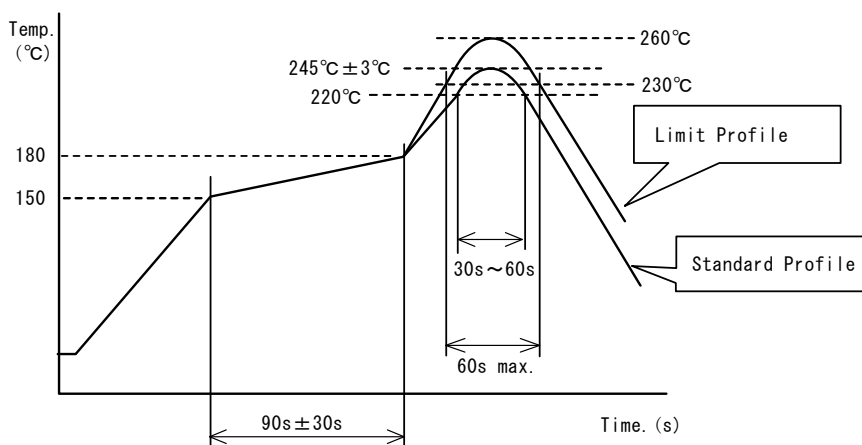
soldering profile

(1)Flow soldering profile



	Standard Profile	Limit Profile
Pre-heating	150°C、60s min.	
Heating	250°C、4s~6s	265°C±3°C、5s
Cycle of flow	2 times	1 time

(2)Reflow soldering profile



	Standard Profile	Limit Profile
Pre-heating	150~180°C、90s ± 30s	
Heating	above 220°C、30s~60s	above 230°C、60s max.
Peak temperature	245 ± 3°C	260°C、10s
Cycle of reflow	2 times	1 time

11.4 Reworking with soldering iron.

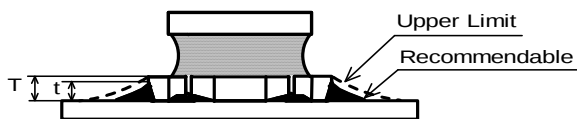
The following conditions must be strictly followed when using a soldering iron.

Pre-heating	150°C、1 min
Tip temperature	350°C max.
Soldering iron output	80W max.
Tip diameter	φ 3mm max.
Soldering time	3(+1,-0)s
Times	2 times

Note : Do not directly touch the products with the tip of the soldering iron in order to prevent the crack on the products due to the thermal shock.

11.5 Solder Volume

- Solder shall be used not to be exceeded the upper limits as shown below.
- Accordingly increasing the solder volume, the mechanical stress to Chip is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance.



$$1/3T \leq t \leq T$$

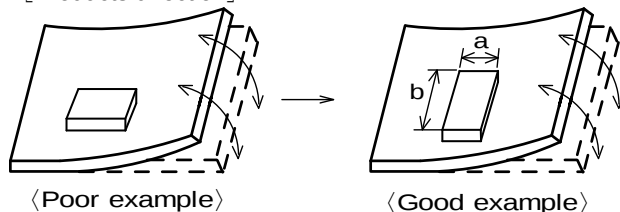
(T: Lower flange thickness)

11.6 Product's location

The following shall be considered when designing and laying out P.C.B.'s.

- (1) P.C.B. shall be designed so that products are not subject to the mechanical stress due to warping the board.

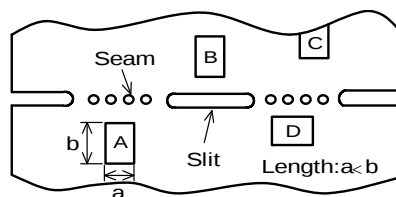
[Products direction]



Products shall be located in the sideways direction (Length: $a < b$) to the mechanical stress.

- (2) Products location on P.C.B. separation

Products (A,B,C,D) shall be located carefully so that products are not subject to the mechanical stress due to warping the board. Because they may be subjected the mechanical stress in order of $A > C > B \cong D$.

**11.7 Cleaning Conditions**

Products shall be cleaned on the following conditions.

- (1) Cleaning temperature shall be limited to 60°C max. (40°C max for IPA.)
- (2) Ultrasonic cleaning shall comply with the following conditions with avoiding the resonance phenomenon at the mounted products and P.C.B.
Power : 20 W / l max. Frequency : 28kHz to 40kHz Time : 5 minutes max.
- (3) Cleaner
 1. Alternative cleaner
 - Isopropyl alcohol (IPA)
 2. Aqueous agent
 - PINE ALPHA ST-100S
- (4) There shall be no residual flux and residual cleaner after cleaning.
In the case of using aqueous agent, products shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- (5) Other cleaning
Please contact us.

11.8 Resin coating

The inductance value may change due to high cure-stress of resin to be used for coating/molding products. An open circuit issue may occur by mechanical stress caused by the resin, amount/cured shape of resin, or operating condition etc. Some resin contains some impurities or chloride possible to generate chlorine by hydrolysis under some operating condition may cause corrosion of wire of coil, leading to open circuit. So, please pay your careful attention when you select resin in case of coating/molding the products with the resin. Prior to use the coating resin, please make sure no reliability issue is observed by evaluating products mounted on your board.

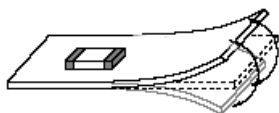
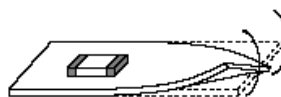
11.9 Caution for use

- Sharp material such as a pair of tweezers or other material such as bristles of cleaning brush, shall not be touched to the winding portion to prevent the breaking of wire.
- Mechanical shock should not be applied to the products mounted on the board to prevent the breaking of the core

11.10 Handling of a substrate

After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

Excessive mechanical stress may cause cracking in the product.

Bending**Twisting****11.11 Storage and Handling Requirements****(1) Storage period**

Use the products within 12 months after delivered.

Solderability should be checked if this period is exceeded.

(2) Storage conditions

- Products should be stored in the warehouse on the following conditions.

Temperature : -10 ~ 40°C

Humidity : 15 to 85% relative humidity No rapid change on temperature and humidity

The electrode of the products is coated with solder. Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.

- Products should not be stored on bulk packaging condition to prevent the chipping of the core and the breaking of winding wire caused by the collision between the products.
- Products should be stored on the palette for the prevention of the influence from humidity, dust and so on.
- Products should be stored in the warehouse without heat shock, vibration, direct sunlight and so on.

(3) Handling Condition

Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

12. Note

- (1) Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2) You are requested not to use our product deviating from the reference specifications.
- (3) The contents of this reference specification are subject to change without advance notice. Please approve our product specifications or transact the approval sheet for product specifications before ordering.